



the

XA-9721A
PATENT APPLICATION

THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

Keisuke TSUKAMOTO et al.

Appln. No.: 10/786,334

Group Art Unit: 2811

Filed: February 26, 2004

Examiner:

For: A SEMICONDUCTOR INTEGRATED CIRCUIT DEVICE AND A METHOD
OF MANUFACTURING THE SAME

* * *

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Applicants wish to make of record the documents recently cited in parent Application No. 10/196,166. The documents a listed on the attached Form PTO-1449.

The Commissioner is hereby authorized to charge to Deposit Account No. 50-1165 any fees under 37 C.F.R. §§ 1.16 and 1.17 that may be required by this paper, and to credit any overpayment to that Account.

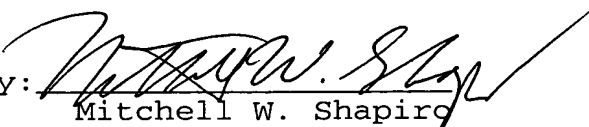
Respectfully submitted,

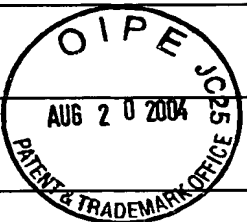
MWS:sk

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August 20, 2004

By:


Mitchell W. Shapiro
Reg. No. 31,568

FORM PTO-1449				Atty. Docket No. XA-9721A		Appln. No. 10/786,334	
<u>LIST OF DOCUMENTS CITED BY APPLICANT</u>				Applicant Keisuke TSUKAMOTO et al.			
				Filing Date February 26, 2004		Group 2811	
				U.S. PATENT DOCUMENTS			
Examiner Initial		Document Number	Date	Name	Class	Sub-class	Filing Date
	AA	5,251,168	10/5/93	Chung et al.	365	51	
	AB	6,590,254	7/8/03	Tanaka (corrs. to Doc AL)	257	315	
	AC	5,946,320	8/31/99	Shimizu et al. (corrs. to Doc AM)	365	185.01	
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
FOREIGN PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Country	Class	Sub-class	Translation
	AL	2001-332708	11/30/01	Japan			Abstract
	AM	11-97652	4/9/99	Japan			Abstract
	AN	11-284134	10/15/99	Japan			Abstract
	AO	11-54730	2/26/99	Japan			Abstract
	AP	11-265891	9/28/99	Japan			Abstract
	AQ	5-235366	9/10/93	Japan			Abstract
	AR	2-111075	4/24/90	Japan			Abstract
	AS						
OTHER (including author, title, date, pertinent pages, etc.)							
	AT						
Examiner				Date Considered			
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							